

Notice of References Cited	Application/Control No. 10/733,242	Applicant(s)/Patent Under Reexamination IWATA ET AL.	
	Examiner Susan S. Lee	Art Unit 2852	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,882,820 B2	04-2005	Shinshi et al.	---/--
*	B	US-2002/0031363	03-2002	Tomita et al.	399/329
*	C	US-6,733,943 B2	05-2004	Finn et al.	---/--
*	D	US-5,214,478 A	05-1993	Honma et al.	---/--
*	E	US-6,284,424 B1	09-2001	Iimura et al.	---/--
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 61205968 A	09-1986	Japan	KAWABATA, YASUSHI	---/--
	O	JP 09068880 A	03-1997	Japan	KANAI, YUTAKA	---/--
	P	JP 05249853 A	09-1993	Japan	YASUDA et al.	---/--
	Q	JP 10228190 A	08-1998	Japan	OIKAWA et al.	---/--
	R	JP 05150679 A	06-1993	Japan	SHOJI et al.	---/--
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.